

Notice of References Cited	Application/Control No. 10/812,970	Applicant(s)/Patent Under Reexamination HUANG ET AL.	
	Examiner Mark Consilvio	Art Unit 2872	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-2003/0046839	03-2003	Oda et al.	40/454
	B	US-2004/0247010	12-2004	Okada et al.	372/102
	C	US-2004/0165823	08-2004	Morris et al.	385/033
	D	US-2004/0042081	03-2004	Te Kolste et al.	359/569
	E	US-2003/0112523	06-2003	Daniell, Stephen	359/626
	F	US-2002/0003661	01-2002	Nakai, Takehiko	359/569
	G	US-5,581,405	12-1996	Meyers et al.	359/571
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Haidner et al., "Binary Subwavelength Structures/Resonance Gratings as Polarization Elements", April 3, 1998, IOP Publishing Ltd., Pure Applied Optics, No. 7, pp. 1347-1361
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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